

Notic of References Cited

Application/Control No.

10/067,370

Applicant(s)/Patent Under
Reexamination
OTSU ET AL.

Examiner

Thao P Le

Art Unit

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*-		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6506664	01-2003	Beyne et al.	438/155
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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